

Search Notes

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10/041,761

Examiner

Hung Q. Dang

Applicant(s)/Patent under
Reexamination

YOON ET AL.

Art Unit

2621

SEARCHED

Class	Subclass	Date	Examiner
386	125	10/2/2007	HQD
369	47.21, 59.25, 275.4	10/2/2007	HQD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC Plus Search	8/2/2006	HQD
Inventos' Names Search	7/25/2006	HQD
USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB (see Search History attached)	8/10/2006- 8/16/2006	HQD
consulted with Thai Tran	12/8/2006	HQD